Features

- EE Programmable 524,288 x 1- and 1,048,576 x 1-bit Serial Memories Designed to Store Configuration Programs for Field Programmable Gate Arrays (FPGAs)
- In-System Programmable via 2-wire Bus
- Simple Interface to SRAM FPGAs
- Compatible with Atmel AT6000, AT40K FPGAs, Altera FLEX[®] Devices, Lucent ORCA[®] FPGAs, Xilinx XC3000, XC4000, XC5200, SPARTAN[®] and Virtex[®] FPGAs
- Cascadable Read Back to Support Additional Configurations or Future Higher-density Arrays
- Low-power CMOS EEPROM Process
- Programmable Reset Polarity
- Available in PLCC Package (Pin-compatible Across Product Family)
- Emulation of Atmel's AT24CXXX Serial EEPROMs
- Available in 3.3V \pm 10% LV and 5V \pm 5% C Versions
- System-friendly READY Pin
- Low-power Standby Mode

Description

The AT17C512/010 and AT17LV512/010 (high-density AT17 Series) FPGA Configuration EEPROMs (Configurators) provide an easy-to-use, cost-effective configuration memory for Field Programmable Gate Arrays. The AT17 Series is packaged in the popular 20-pin PLCC. The AT17 Series family uses a simple serial-access procedure to configure one or more FPGA devices. The AT17 Series organization supplies enough memory to configure one or multiple smaller FPGAs. The user can select the polarity of the reset function by programming four EEPROM bytes. These devices also support a write protection mode and a system-friendly READY pin, which signifies a "good" power level to the FPGA and can be used to ensure reliable system power-up.

The AT17 Configurator Series can be programmed with industry-standard programmers, or Atmel's ATDH2200E Programming Kit.

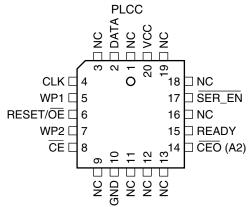
AMEL

FPGA Configuration EEPROM Memory

512K and 1M

AT17C512 AT17LV512 AT17C010 AT17LV010

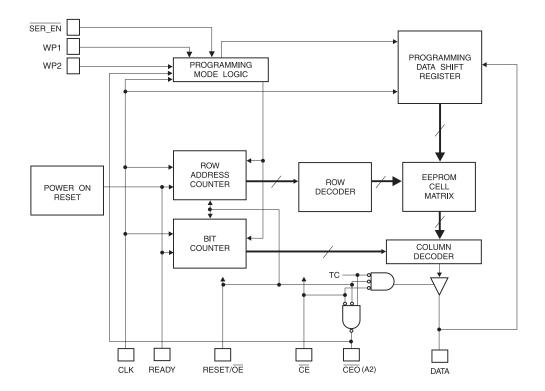
Pin Configurations







Block Diagram



FPGA Master Serial The I/O and logic functions of the FPGA and their associated interconnections are established by a configuration program. The program is loaded either automatically Mode Summary upon power-up, or on command, depending on the state of the FPGA mode pins. In Master Mode, the FPGA automatically loads the configuration program from an external memory. The AT17 Serial Configuration EEPROM has been designed for compatibility with the Master Serial Mode. This document discusses the AT40K FPGA interface. For more details or AT6000 FPGA applications, please reference "AT40K Series Configuration" or "AT6000 Series Configuration" application notes. **Controlling the High-**Most connections between the FPGA device and the AT17 Serial Configuration EEPROM are simple and self-explanatory: density AT17 Series The DATA output of the AT17 Series Configurator drives DIN of the FPGA devices. Serial EEPROMs **During Configuration** The master FPGA CCLK output drives the CLK input of the AT17 Series Configurator. The \overline{CEO} output of any AT17C/LV512/010 drives the \overline{CE} input of the next AT17C/LV512/010 in a cascade chain of EEPROMs. SER EN must be connected to VCC, (except during ISP). The READY pin is available as an open-collector indicator of the device's reset status; it is driven Low while the device is in its power-on reset cycle and released (tri-stated) when the cycle is complete.

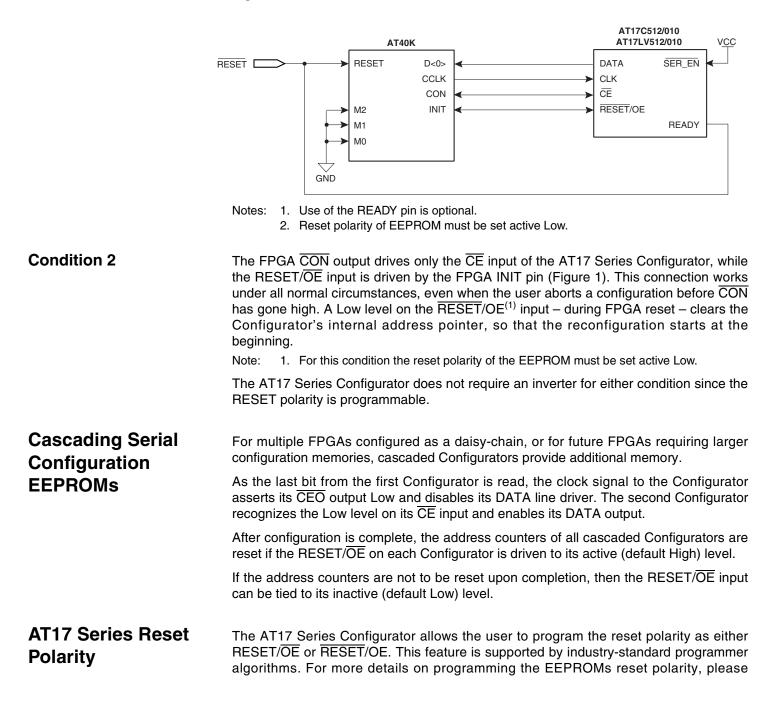
There are two different ways to use the inputs \overline{CE} and \overline{OE} .

Condition 1

The simplest connection is to have the FPGA $\overline{\text{CON}}$ pin drive both $\overline{\text{CE}}$ and $\text{RESET}/\overline{\text{OE}}^{(1)}$ in parallel. Due to its simplicity, however, this method will fail if the FPGA receives an external reset condition during the configuration cycle. If a system reset is applied to the FPGA, it will abort the original configuration and then reset itself for a new configuration, as intended. Of course, the AT17 Series Configurator does not see the external reset signal and will not reset its internal address counters and, consequently, will remain out of sync with the FPGA for the remainder of the configuration cycle.

Note: 1. For this condition, the reset polarity of the EEPROM must be set active High.

Figure 1. Condition 2 Connection







reference the "Programming Specification for Atmel's FPGA Configuration EEPROMs" application note.

Programming Mode The programming mode is entered by bringing SER_EN Low. In this mode the chip can be programmed by the 2-wire serial bus. The programming is done at VCC supply only. Programming super voltages are generated inside the chip. See the "Programming Specification for Atmel's FPGA Configuration EEPROMs" application note for further information. The AT17C parts are read/write at 5V nominal. The AT17LV parts are read/write at 3.3V nominal.

Standby Mode The AT17C/LV512/010 Series Configurator enters a low-power standby mode whenever CE is asserted High. In this mode, the Configurator consumes less than 0.5 mA of current at 5V. The output remains in a high impedance state regardless of the state of the OE input.

Pin Configurations

20 PLCC Pin	Name	I/O	Description
2	DATA	I/O	Three-state DATA output for configuration. Open-collector bi-directional pin for programming.
4	CLK	I	Clock input. Used to increment the internal address and bit counter for reading and programming.
5	WP1	I	WRITE PROTECT (1). Used to protect portions of memory during programming. Disabled by default due to internal pull-down resistor. This input pin is not used during FPGA loading operations. See the "Programming Specification" application note for more details.
6	RESET/OE	I	RESET/Output Enable input (when SER_EN is High). A Low level on both the CE and RESET/OE inputs enables the data output driver. A High level on RESET/OE resets both the address and bit counters. The logic polarity of this input is programmable as either RESET/OE or RESET/OE. This document describes the pin as RESET/OE.
7	WP2	I	WRITE PROTECT (2). Used to protect portions of memory during programming. Disabled by default due to internal pull-down resistor. This input pin is not used during FPGA loading operations. See the "Programming Specification" application note for more details.
8	CE	I	Chip Enable input. Used for device selection. A Low level on both \overline{CE} and \overline{OE} enables the data output driver. A High level on \overline{CE} disables both the address and bit counters and forces the device into a low-power standby mode. Note that this pin will <u>not</u> enable/disable the device in the 2-wire Serial Programming Mode (i.e., when \overline{SER}_{EN} is Low).
10	GND		Ground pin. A 0.2 µF decoupling capacitor between VCC and GND is recommended.
14	CEO	Ο	Chip Enable Output. This signal is asserted Low on the clock cycle following the last bit read from the memory. It will stay Low as long as \overline{CE} and \overline{OE} are both Low. It will then follow \overline{CE} until \overline{OE} goes High. Thereafter, \overline{CEO} will stay High until the entire EEPROM is read again.
14	A2	I	Device selection input, A2. This is used to enable (or select) the device during programming (i.e., when SER_EN is Low; see the "Programming Specification" application note for more details).
15	READY	0	Open collector reset state indicator. Driven Low during power-up reset, released when power-up is complete. (Recommend a 4.7 k Ω pull-up on this pin if used).
17	SER_EN	Ι	Serial enable must be held High during FPGA loading operations. Bringing SER_EN Low enables the 2-wire Serial Programming Mode.
20	VCC		+3.3V/+5V power supply pin.

Absolute Maximum Ratings*

Operating Temperature55°C to +125°C
Storage Temperature65°C to +150°C
Voltage on Any Pin with Respect to Ground0.1V to V_{CC} +0.5V
Supply Voltage (V _{CC})0.5V to +7.0V
Maximum Soldering Temp. (10 sec. @ 1/16 in.)260°C

*NOTICE: Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those listed under Operating Conditions is not implied. Exposure to Absolute Maximum Ratings conditions for extended periods of time may affect device reliability.

Operating Conditions

			AT17CXXX		AT17LVXXX		
Symbol	Description		Min	Max	Min	Max	Units
	Commercial	Supply voltage relative to GND -0°C to +70°C	4.75	5.25	3.0	3.6	V
V _{CC}	Industrial	Supply voltage relative to GND -40°C to +85°C	4.5	5.5	3.0	3.6	V
	Military	Supply voltage relative to GND -55°C to +125°C	4.5	5.5	3.0	3.6	V





DC Characteristics

 V_{CC} = 5V \pm 5% Commercial/5V \pm 10% Ind./Mil.

Symbol	Description		Min	Max	Units
V _{IH}	High-level input voltage		2.0	V _{cc}	V
V _{IL}	Low-level input voltage		0	0.8	V
V _{OH}	High-level output voltage (I _{OH} = -4 mA)		3.86		V
V _{OL}	Low-level output voltage (I _{OL} = +4 mA)	Commercial		0.32	V
V _{OH}	High-level output voltage (I _{OH} = -4 mA)	la du etal	3.76		V
V _{OL}	Low-level output voltage (I _{OL} = +4 mA)	Industrial		0.37	V
V _{OH}	High-level output voltage (I _{OH} = -4 mA)	h dilita - ma	3.7		V
V _{OL}	Low-level output voltage (I _{OL} = +4 mA)	Military		0.4	V
I _{CCA}	Supply current, active mode			10	mA
IL	Input or output leakage current ($V_{IN} = V_{CC}$ or GND)		-10	10	μA
1		Commercial		0.5	mA
I _{CCS}	Supply current, standby mode	Industrial/Military		0.5	mA

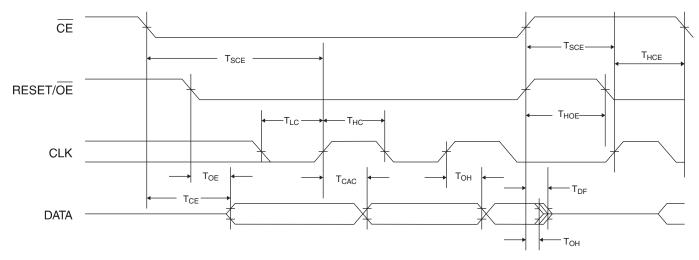
DC Characteristics

 $V_{CC}=3.3V\pm10\%$

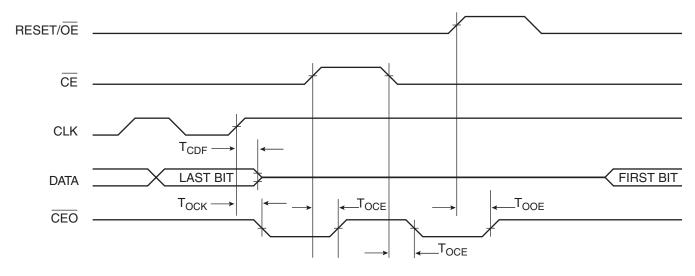
Symbol	Description	Description			Units
V _{IH}	High-level input voltage		2.0	V _{CC}	V
V _{IL}	Low-level input voltage		0	0.8	V
V _{OH}	High-level output voltage (I _{OH} = -2.5 mA)		2.4		V
V _{OL}	Low-level output voltage (I _{OL} = +3 mA)	Commercial		0.4	V
V _{OH}	High-level output voltage (I _{OH} = -2 mA)		2.4		V
V _{OL}	Low-level output voltage (I _{OL} = +3 mA)	Industrial		0.4	V
V _{OH}	High-level output voltage (I _{OH} = -2 mA)	N Allian ma	2.4		V
V _{OL}	Low-level output voltage (I _{OL} = +2.5 mA)	Military		0.4	V
I _{CCA}	Supply current, active mode	I		5	mA
I _L	Input or output leakage current (VIN = VCC or GNI	D)	-10	10	μA
		Commercial		100	μA
I _{CCS}	Supply current, standby mode	Industrial/Military		100	μA

AT17C/LV512/010

AC Characteristics



AC Characteristics When Cascading







AC Characteristics for AT17C512/010

		Commercial		Industria	Industrial/Military ⁽¹⁾	
Symbol	Description	Min	Max	Min	Max	Units
T _{OE} ⁽²⁾	OE to Data Delay		30		35	ns
T _{CE} ⁽²⁾	CE to Data Delay		45		45	ns
T _{CAC} ⁽²⁾	CLK to Data Delay		50		50	ns
Т _{ОН}	Data Hold From \overline{CE} , \overline{OE} , or CLK	0		0		ns
$T_{DF}^{()}$	CE or OE to Data Float Delay		50		50	ns
T _{LC}	CLK Low Time	20		20		ns
T _{HC}	CLK High Time	20		20		ns
T _{SCE}	CE Setup Time to CLK (to guarantee proper counting)	20		25		ns
T _{HCE}	CE Hold Time from CLK (to guarantee proper counting)	0		0		ns
T _{HOE}	OE High Time (guarantees counter Is reset)	20		20		ns
F _{MAX}	MAX Input Clock Frequency	15		15		MHz

 V_{CC} = 5V \pm 5% Commercial/V_{CC} = 5V \pm 10% Ind./Mil.

Notes: 1. Preliminary specifications for military operating range only.

2. AC test load = 50 pF.

3. Float delays are measured with 5 pF AC loads. Transition is measured ±200 mV from steady state active levels.

AC Characteristics for AT17C512/010 When Cascading

 V_{CC} = 5V± 5% Commercial/V_{CC} = 5V ± 10% Ind./Mil.

			Commercial		Industrial/Military ⁽¹⁾	
Symbol	Description	Min	Max	Min	Max	Units
T _{CDF} ⁽³⁾	CLK to Data Float Delay		50		50	ns
T _{OCK} ⁽²⁾	CLK to CEO Delay		35		40	ns
T _{OCE} ⁽²⁾	CE to CEO Delay		35		35	ns
T _{OOE} ⁽²⁾	RESET/OE to CEO Delay		30		30	ns
F _{MAX}	MAX Input Clock Frequency	12.5		12.5		MHz

Notes: 1. Preliminary specifications for military operating range only.

2. AC test load = 50 pF.

3. Float delays are measured with 5 pF AC loads. Transition is measured ±200 mV from steady state active levels.

AT17C/LV512/010

AC Characteristics for AT17LV512/010

 $V_{CC}=3.3V\pm10\%$

			Commercial		Industrial/Military ⁽¹⁾	
Symbol	Description	Min	Max	Min	Max	Units
T _{OE} ⁽²⁾	OE to Data Delay		50		55	ns
T _{CE} ⁽²⁾	CE to Data Delay		55		60	ns
T _{CAC} ⁽²⁾	CLK to Data Delay		55		60	ns
Т _{он}	Data Hold From \overline{CE} , \overline{OE} , or CLK	0		0		ns
T _{DF} ⁽³⁾	CE or OE to Data Float Delay		50		50	ns
T _{LC}	CLK Low Time	25		25		ns
T _{HC}	CLK High Time	25		25		ns
T _{SCE}	CE Setup Time to CLK (to guarantee proper counting)	30		35		ns
T _{HCE}	CE Hold Time from CLK (to guarantee proper counting)	0		0		ns
T _{HOE}	OE High Time (guarantees counter is reset)	25		25		ns
F _{MAX}	MAX Input Clock Frequency	15		10		MHz

Notes: 1. Preliminary specifications for military operating range only.

2. AC test load = 50 pF.

3. Float delays are measured with 5 pF AC loads. Transition is measured ±200 mV from steady state active levels

AC Characteristics for AT17LV512/010 When Cascading

 $V_{CC}=3.3V\pm10\%$

			Commercial		Industrial/Military ⁽¹⁾	
Symbol	Description	Min	Max	Min	Max	Units
T _{CDF} ⁽³⁾	CLK to Data Float Delay		50		50	ns
T _{OCK} ⁽²⁾	CLK to CEO Delay		50		55	ns
T _{OCE} ⁽²⁾	CE to CEO Delay		35		40	ns
T _{OOE} ⁽²⁾	RESET/OE to CEO Delay		35		35	ns
F _{MAX}	MAX Input Clock Frequency	12.5		10		MHz

Notes: 1. Preliminary specifications for military operating range only.

2. AC test load = 50 pF.

3. Float delays are measured with 5 pF AC loads. Transition is measured ±200 mV from steady state active levels.





Ordering Information – 5V Devices

Memory Size	Ordering Code	Package	Operation Range
512K	AT17C512-10JC	20J	Commercial (0°C to 70°C)
	AT17C512-10JI	20J	Industrial (-40°C to 85°C)
1M	AT17C010-10JC	20J	Commercial (0°C to 70°C)
	AT17C010-10JI	20J	Industrial (-40°C to 85°C)

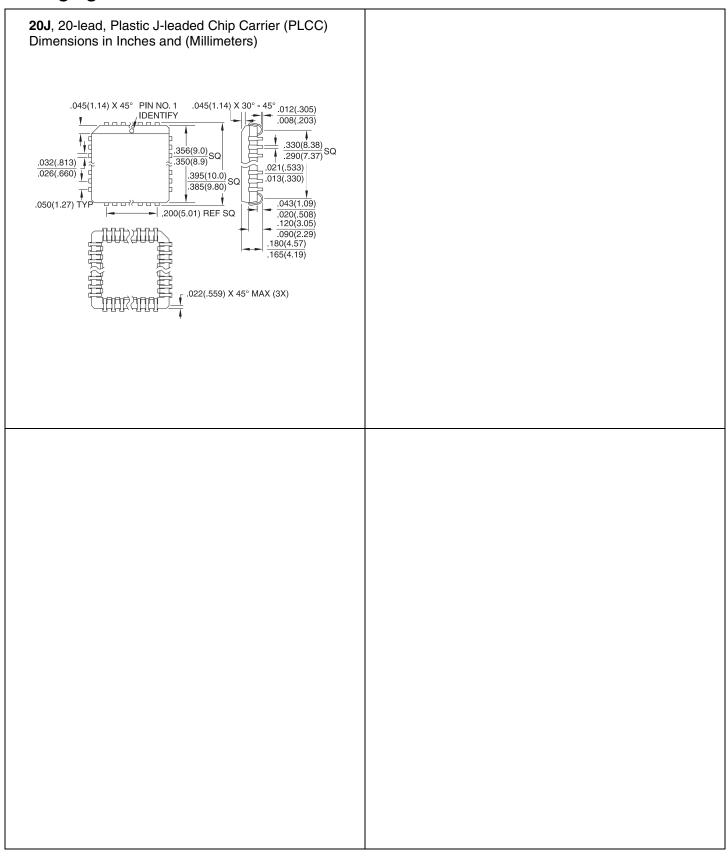
Ordering Information – 3.3V Devices

Memory Size	Ordering Code	Package	Operation Range		
512K	AT17LV512-10JC	20J	Commercial (0°C to 70°C)		
	AT17LV512-10JI	20J	Industrial (-40°C to 85°C)		
1M	AT17LV010-10JC	20J	Commercial (0°C to 70°C)		
	AT17LV010-10JI	20J	Industrial (-40°C to 85°C)		

	Package Type
20J	20-lead, Plastic J-leaded Chip Carrier (PLCC)

AT17C/LV512/010

Packaging Information







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